

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Examination

RUBINSTENN ET AL.

Examiner

Kimbhinh T. Nguyen

Art Unit

2671

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,362,850	03-2002	Alsing et al.	348/239
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**NON-PATENT DOCUMENTS**

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	U	Wu et al. "Skin aging Estimation by Facial Simulation", IEEE 1999, pages 210-219.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.